

# **Notice of References Cited**

Application/Control No. <b>09/635,138</b>		Applicant(s)/Patent Under Reexam <b>Sugiura et al.</b>	
Examiner <b>Tuyen T. Nguyen</b>		Art Unit <b>2832</b>	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,870,012	2/1999	Sakamaki et al.	336	107
B	4,744,337	5/1988	Ebinuma et al.	123	41.66
C					
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K					
L					
M					

## **FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
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## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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